

Dual N-Channel 20V, 3.8mΩ Typ. Power MOSFET

Description

Features

• 20V, 50A

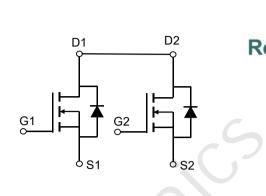
 $R_{DS(ON)}$ Typ = 3.8m Ω @ V_{GS} = 4.5V

 $R_{DS(ON)}$ Typ = 4.9m Ω @ V_{GS} = 2.5V

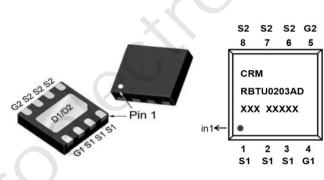
- Advanced Trench Technology
- Excellent R_{DS(ON)} and Low Gate Charge
- Lead Free
- 100% UIS TESTED!
- 100% ΔVds TESTED!

Application

- Load Switch
- PWM Application
- Power Management



Schematic Diagram



Marking and Pin Assignment

Package Marking and Ordering Information

| Device | Marking | Package | Outline | Reel Size | Reel (pcs) | Per Carton (pcs) |
|---------------|---------------|-----------|---------|-----------|------------|------------------|
| CRMRBTU0203AD | CRMRBTU0203AD | DFN3x3-8L | TAPING | 7" | 3000 | 120000 |

Absolute Maximum Ratings (@ T_J = 25°C unless otherwise specified)

| Symbol | Parameter | | Value | Units |
|--|---|------------------------|------------|-------|
| V _{DS} | Drain-to-Source Voltage | | 20 | V |
| V _{GS} | Gate-to-Source Voltage | | ±12 | V |
| | Continuous Drain Current | T _C = 25°C | 50 | А |
| Ι _D | Continuous Drain Current | T _C = 100°C | 30 | А |
| I _{DM} | Pulsed Drain Current ⁽¹⁾ | | 200 | А |
| E _{AS} | Single Pulsed Avalanche Energy ⁽²⁾ | | 85.5 | mJ |
| P _D | Power Dissipation | T _C = 25°C | 28.1 | W |
| $R_{	ext{	ext{	ext{	ext{	ext{	ext{	ext{	ext$ | Thermal Resistance, Junction to Case | | 6.9 | °C/W |
| T_{J},T_{STG} | Junction & Storage Temperature Range | | -55 to 150 | °C |



Electrical Characteristics (T_J = 25°C unless otherwise specified)

| Symbol | Parameter | Conditions | Min. | Тур. | Max. | Uni |
|----------------------|--|--|----------|------|------|-----|
| Off Chara | acteristics | | | | | |
| V _{(BR)DSS} | Drain-Source Breakdown Voltage | I_{D} = 250 μ A, V _{GS} = 0V | 20 | - | - | V |
| I _{DSS} | Zero Gate Voltage Drain Current | V _{DS} = 20V, V _{GS} = 0V | - | - | 1.0 | μA |
| I _{GSS} | Gate-Body Leakage Current | $V_{DS} = 0V, V_{GS} = \pm 12V$ | - | - | ±100 | nA |
| On Chara | acteristics | | | | 6 | |
| $V_{GS(th)}$ | Gate Threshold Voltage | V_{DS} = V_{GS} , I_D = 250 μ A | 0.4 | 0.7 | | V |
| P | | V_{GS} = 4.5V, I_{D} = 5A | - | 3.8 | 5 | mΩ |
| R _{DS(ON)} | Static Drain-Source ON-Resistance ⁽³⁾ | V _{GS} = 2.5V, I _D = 3A | - | 4.9 | 6.4 | mΩ |
| Dynamic | Characteristics | | | | | |
| C _{iss} | Input Capacitance | | - | 2860 | - | pF |
| C_{oss} | Output Capacitance | V _{GS} = 0V, V _{DS} = 10V, f = 1MHz | X-\ | 343 | - | pF |
| C _{rss} | Reverse Transfer Capacitance | 1 - 11/11/2 | | 290 | - | pF |
| Q _g | Total Gate Charge | 0 | <u> </u> | 40 | - | nC |
| Q_gs | Gate Source Charge | $V_{GS} = 0$ to 4.5V $V_{DS} = 10V$, $I_{D} = 5A$ | - | 3 | - | nC |
| Q_{gd} | Gate Drain("Miller") Charge | $v_{\rm DS} = 10 v$, $v_{\rm D} = 0.1$ | - | 7 | - | nC |
| Switching | g Characteristics | | | | | |
| t _{d(on)} | Turn-On DelayTime | | - | 17 | - | ns |
| t _r | Turn-On Rise Time | V _{GS} = 4.5V, V _{DD} = 10V | - | 45 | - | ns |
| t _{d(off)} | Turn-Off DelayTime | I_D = 5A, R_{GEN} = 3 Ω | - | 81.5 | - | ns |
| t _f | Turn-Off Fall Time | | - | 70 | - | ns |
| Drain-So | urce Diode Characteristics and I | Max Ratings | | | | |
| I _S | Maximum Continuous Drain to Source D | iode Forward Current | - | - | 50 | А |
| I _{SM} | Maximum Pulsed Drain to Source Diode | Forward Current | - | - | 200 | А |
| | Drain to Source Diode Forward Voltage | V _{GS} = 0V, I _S = 5A | _ | - | 1.2 | V |

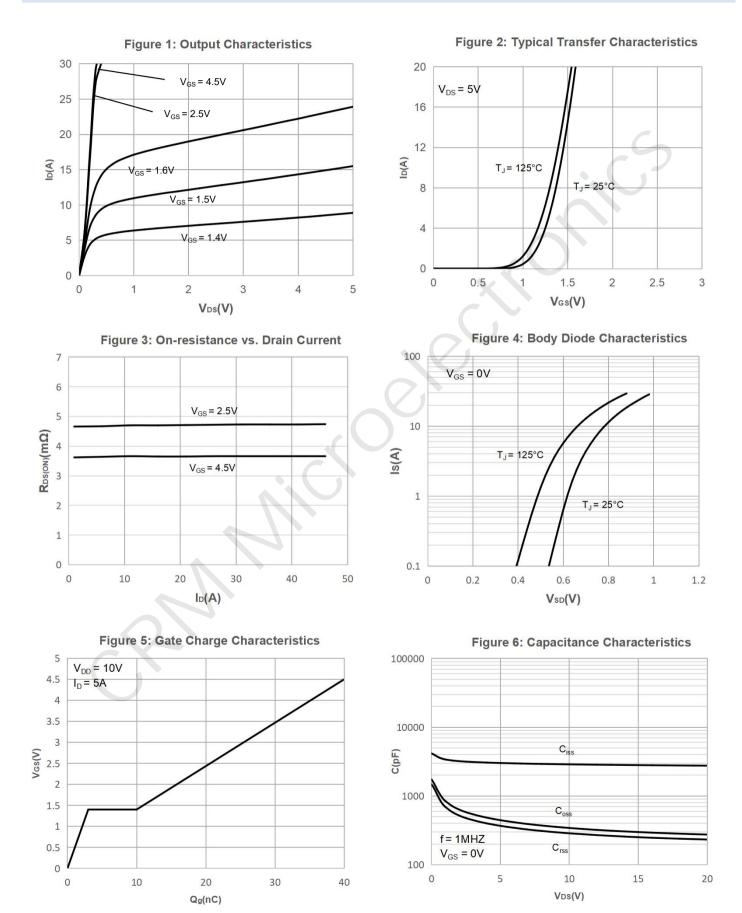
2. E_{AS} condition: Starting T_J=25°C, V_{DD}=10V, V_G=10V, R_G=25ohm, L=0.5mH, I_{AS}=18.5A

3. Pulse Test: Pulse Width≤300µs, Duty Cycle≤0.5%.



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Typical Performance Characteristics

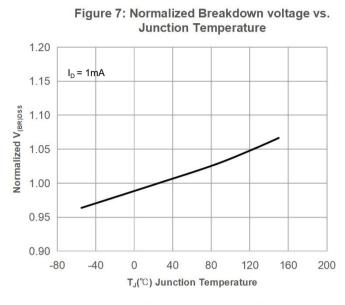


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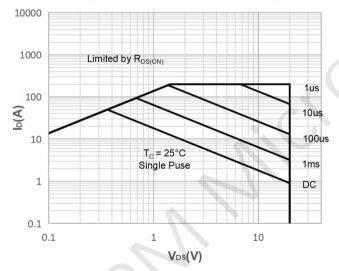


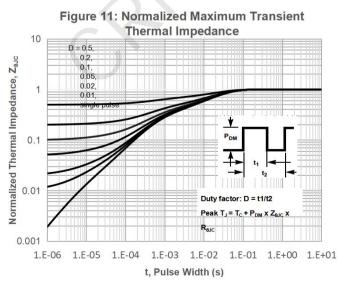
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Typical Performance Characteristics









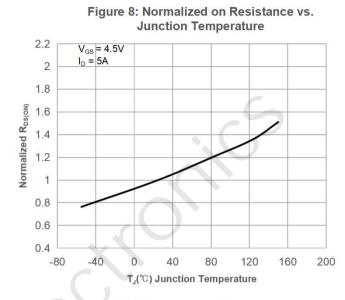


Figure 10: Maximum Continuous Drian Current vs. Case Temperature

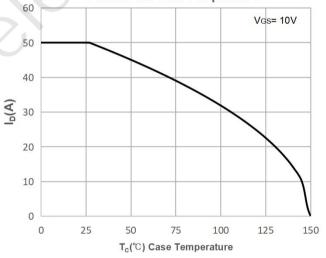
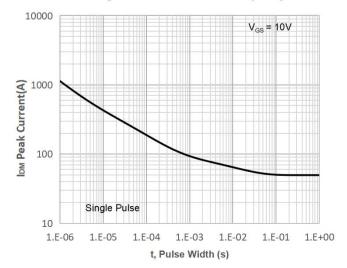


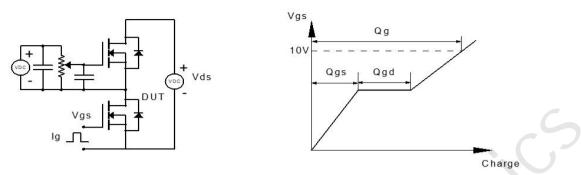
Figure 12: Peak Current Capacity





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Test Circuit





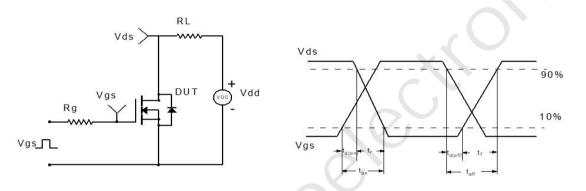


Figure 2: Resistive Switching Test Circuit & Waveform

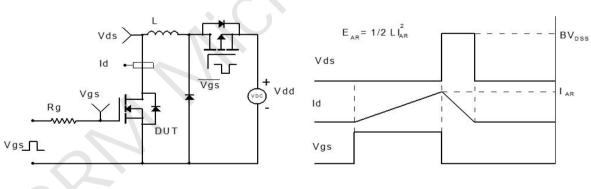


Figure 3: Unclamped Inductive Switching Test Circuit& Waveform

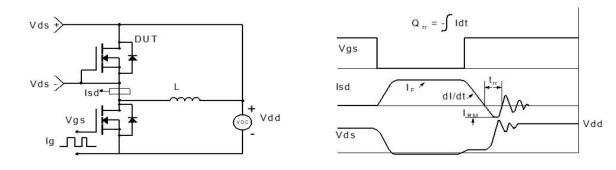
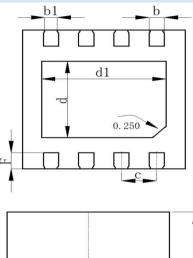


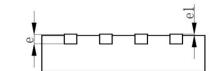
Figure 4: Diode Recovery Test Circuit & Waveform



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Package Mechanical Data(DFN3x3-8L)







| | COMMON DIN | IENSION (MM) | | |
|--------|------------|--------------|--------|--|
| PKG | DFN 3×3-8L | | | |
| SYMBOL | MIN | ТҮР | MAX | |
| A | 2.950 | 3.000 | 3. 050 | |
| A1 | 2.950 | 3.000 | 3. 050 | |
| b | 0.255 | 0. 280 | 0.305 | |
| b1 | 0.200 | 0. 230 | 0.260 | |
| С | 0.625 | 0. 650 | 0.675 | |
| d | 1.625 | 1.650 | 1.675 | |
| d1 | 2.275 | 2. 300 | 2.325 | |
| е | 0.195 | 0.203 | 0. 233 | |
| e1 | | 0. 020 | 0.050 | |
| Е | 0.720 | 0.750 | 0. 780 | |
| F | 0.320 | 0.350 | 0.380 | |

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